

HIGH DENSITY INDUCTOR AND METHOD FOR PRODUCING SAME

BACKGROUND OF THE INVENTION

Field of the Invention

5 The present invention relates to an inductor for use in an electronic circuit and a method for producing the same. More specifically, the present invention relates to a high density inductor that is reduced in size to allow high density mounting on a
10 substrate and a method of producing such a high density inductor.

Related Background Art

 An inductor as an electronic part has the property of storing current energy. Inductors are
15 used in DC-DC converters, switching power sources and other devices and equipped in various electronic apparatuses.

 In recent years, with downsizing and thickness reduction of electronic apparatuses such as cellular
20 phones and personal digital assistants (PDAs), downsizing and thickness reduction of inductors have been demanded.

 In the following, the structure and production method of conventional inductors will be described.

25 Figs. 7A and 7B are perspective views showing inductors according to a first prior art. As shown in these drawings, the inductor 1 according to the

first prior art has a structure in which a wire 2 having a circular or rectangular cross section is helically wound around a core 3. (The cross section of the wire 2 may also be triangular.)

5 Figs. 8A and 8B illustrates a process for producing an inductor according to a second prior art. In the producing process of the inductor according to the second prior art, firstly, an insulating member and an electroconductive member 5 in the form of webs
10 are layered and rolled around a cylindrical core 6 as shown in Fig. 8A. After the insulating member and the electroconductive member 5 are rolled around the core 6, the roll is sliced in the radial direction, so that a plurality of inductors 4 are formed as
15 shown in Fig. 8B.

There is a limit to the downsizing and thickness reduction of the above-described inductor, since its production process includes a mechanical operation of wrapping the electroconductive member
20 around the core.

In order to attain downsizing and thickness reduction of inductor parts, there has been proposed a process for producing a coil by forming a wire layer(s) utilizing vapor deposition or sputtering
25 (i.e. so-called thin film technology) and patterning the wire layer utilizing a resist or the like.

Figs. 9A to 9D schematically illustrate a

process for forming a coil utilizing a thin film technology. Firstly, as shown in Fig. 9A, an electrode film 8 is formed on the surface of a substrate 7 with an insulating layer between by vapor deposition or sputtering, and then a resist is applied to the upper surface of the electrode film 8 by a spin coating process or the like. Then photo etching is performed with a mask (not shown) so that a pattern of the resist 9 is formed as shown in Fig. 9B. After the resist 9 has been patterned, the grooved portions 10 are stopped by vapor deposition, sputtering or deposition of a metal by plating as shown in Fig. 9C. Then superfluous portions on the top surface are ground. After that, the resist 9 is removed, and then the electrode film 8 is removed by milling or wet etching, so that a coil 11 is formed as shown in Fig. 9D. Fig. 10 shows the external appearance of the coil 11 that has been formed by the above-described thin film technology.

The inductor formed by the thin film technology has a relatively small dimension in thickness as compared to its area. Consequently, its magnetic circuit is generally longer than that of conventional wire-wound coils having the same inductance.

In order to avoid deterioration of inductance efficiency (i.e. inductance per unit volume) caused by such elongation of the magnetic circuit, the coil

may be designed to have as small spaces within the coil as possible and as large a thickness as possible in order for the coil to have a high aspect ratio.

For example, a power inductor through which a current
5 more than several hundred milliamperes flows, the aforementioned coil 11 is designed to have a high aspect ratio with a height of 50 μ m or, in some cases, more than 200 μ m.

In addition to the above-described process, a
10 process of forming a coil in which copper is naturally grown on the surface of a sheet substrate by plating has also been known. Figs. 11A to 11D show a process of forming a coil by means of plating. Firstly, as shown in Fig. 11A, an electrode film 8
15 and a resist 9 are formed on a substrate 7 with an insulating layer between. After that, patterning by means of the photo etching is performed. After the patterning, a material for forming a coil (e.g. copper) is deposited in the groove portions 10 with
20 the electrode film 8 being an electrode so that copper is naturally grown. The growth of the deposit member 12 is stopped just before portions of the deposit member 12 growing in adjacent grooved portions 10 are in contact with each other so that
25 short circuit between those portions of the deposit member 12 is prevented from occurring. After that, the resist 9 is removed as shown in Fig. 11C, and the

electrode film 8 is removed by milling or wet etching as shown in Fig. 11D. Thus a coil 11 is produced.

Other methods of producing a coil have also been known. According to one of them, a coil with a
5 high aspect ratio is formed by forming a film of an electroconductive material having a thickness corresponding to the thickness of the coil and etching the electroconductive film to form narrow and deep grooves in the electroconductive material (see,
10 for example, in Japanese Patent Application Laid-Open No. 2001-102235)

According to another method, a layer of an electroconductive deposit material for forming a coil that has a mushroom cross section profile is grown on
15 an exposed portion of an underlying thin layer and a coating portion of a positive photoresist mask pattern adjacent thereto (see, for example, Japanese Patent Application Laid-Open No. H11-204361).

According to still another method, a flat coil
20 formed on one substrate and a flat coil that is formed on another substrate in such a way as to be symmetrical with the former flat coil are arranged to overlap with each other so that the coil surfaces are electrically connected with each other (see, for
25 example Japanese Patent Application Laid-Open No. H11-176639).

However, the above-mentioned coils formed by a

thin film technology or the above-mentioned methods of forming a coil utilizing natural growth by plating suffer from the following problems.

In the coil produced by the above-described thin film technology, the thickness of the resist 9 (i.e. dimension B in Fig. 9B) is large as compared to the width of the resist 9 (i.e. dimension A in Fig. 9B) that corresponds to the space between wires of the coil. In other words, the coil has a cross section with a so-called high aspect ratio (specifically, a resist aspect ratio of equal to or more than 3). Thus, the resist pattern formed after the photo etching becomes slender, and therefore the resist is decreased in strength. Consequently, the resist can be bent as shown in Fig. 12 or removed by pressure of the plating solution or cleaning fluid. In connection with this, inventors' investigations have revealed that when the resist aspect is 5 to 7 or more, it is impossible to produce coils with an acceptable yield.

Furthermore, in the production of a coil with a thickness of more than several tens microns, if the space between the wires of the coil (i.e. the intervals in the radial direction of a spiral coil) is required to be reduced, it is necessary to decrease the wavelength of the exposure light in order to enhance the resolution of the exposure

apparatus. However, if the wavelength of the exposure light is decreased, the depth of focus upon exposure is decreased. This causes another problem, that is, the coil pattern cannot be formed deeply in the vertical direction. (On the other hand, when the wavelength of the exposure light is increased, although the depth of focus is increased, the resolution is decreased. As a result, it is impossible to reduce the space between the wires of the coil.)

In addition, use of a magnetic substrate as the substrate 7 is effective in downsizing and enhancement of density of the coil produced by a thin film technology, since the shortest magnetic path can be formed by forming the magnetic path of the coil directly with an insulating layer between. However, in that case, it is necessary to provide a returning magnetic path arranged to coincide with the path of the magnetic lines of force. Consequently, it is not possible to increase the substrate surface density, and therefore it is not possible to increase productivity. In addition, use of a material that are hard to be processed, such as a ferrite, for the substrate causes an increase in cost.

In contrast, in the case that a coil is formed on a non-magnetic substrate and combined with a core member, it is necessary for the sheet to have a

thickness of about 35 to 100 μ m from the viewpoint of rigidity requirement. Consequently, the ratio of the cross sectional area of the sheet to the cross sectional area of the coil becomes large, so that the occupation density of the coil in the interior of the inductor is unfavorably decreased. The decrease in the occupation density is exaggerated as the size of the coil is reduced, since the thickness of the sheet will not be changed. In any case, the substrate is occupied within the magnetic path, and the downsizing and density enhancement is hindered.

On the other hand, in the process of forming a coil by natural growth by plating, it is possible to reduce the intervals between the deposit member 12 to as small as 10 to 20 microns. However, since the deposit member 12 is formed by natural growth, it is not possible to increase the aspect ratio of the coil to more than 1. In view of this, as a method for increasing the thickness of the coil 11, there has been proposed a method in which the substrate 7 is prepared as a thin sheet and a similar coil is also formed on the backside of the sheet-like substrate. With this method, the electroconductive area of the coil can be increased.

However, even in the above-described method in which coils 11 are formed on both sides of a substrate, it is necessary for the sheet to have a

thickness of about 35 to 100 μ m from the viewpoint of rigidity requirement. Consequently, the ratio of the cross sectional area of the sheet to the cross sectional area of the coil becomes large, so that the occupation density of the coil in the interior of the inductor is unfavorably decreased. The decrease in the occupation density is exaggerated as the size of the coil is reduced, since the thickness of the sheet will not be changed.

10 In the process disclosed in Japanese Patent Application Laid-Open No. 2001-102235, there is the risk that a pattern can be bent or removed or the depth of focus at the exposure wavelength can be narrowed like in the case of the above-described coil
15 produced by utilizing a thin film technology.

 In the process disclosed in Japanese Patent Application Laid-Open No. H11-204361, there is a limit to improvement in the aspect ratio, since the electroconductive deposit layer of the coil is formed
20 in a mushroom shape. Therefore, it is difficult for that process to attain the aspect ratio that can be realized by the present invention.

 In the process disclosed in Japanese Patent Application Laid-Open No. H11-176639, although the aspect ratio of a coil is improved by arranging coils
25 to overlap with each other. However, since the overlapping coils are only a pair of coils, it is

difficult for this process also to attain the aspect ratio that can be realized by the present invention.

SUMMARY OF THE INVENTION

5 The present invention has been made in view of the above-described problems. An object of the present invention is to provide a high density inductor and a method for producing the same with which improvement in the aspect ratio up to high
10 aspect ratios as well as downsizing of the inductor can be realized.

 The present invention has been made based on the inventive concept that a coil with a high aspect ratio can be produced eventually by forming coils
15 with small aspect ratios utilizing a thin film technology while piling up those coils in the thickness direction.

 According to the present invention there is provided a high density inductor comprising a coil
20 having a spiral shape and a core member disposed in such a way as to coincide with a path of a magnetic line of force generated by the coil, wherein the coil has a form in which a plurality of wire layers are piled up in a thickness direction, and the wire
25 layers are formed by a thin film forming process. It is preferable that the ratio of the thickness of the coil to the line width of the wire layers be equal to

or more than 1.

According to the present invention there is also provided a method for producing a high density inductor comprising the steps of forming a coil
5 having a spiral shape, sealing the coil in the interior of a core member, and forming a terminal electrode for allowing electric conduction to the coil on the outside of the core member, wherein the coil is formed by repeating a process of forming a
10 wire layer by means of a thin film forming process and a process of forming an additional wire layer on top of the wire layer by means of the thin film forming process to pile up the wire layers.

According to a more specific form of the
15 present invention, there is provided a method for producing a high density inductor comprising the steps of forming a coil having a spiral shape, sealing the coil in the interior of a core member, and forming a terminal electrode for allowing
20 electric conduction to the coil on the outside of the core member, wherein the coil is formed by a process comprising the steps of forming a groove portion corresponding to the shape of the coil in a resist by photo etching, depositing a metal in the groove by
25 plating to form a wire layer, then removing the resist, applying the resist up to a height beyond the wire layer, forming a groove portion on top of the

wire layer by photo etching again, then forming an additional wire layer by depositing the metal in the groove portion by plating, and repeating piling-up of the wire layers to form the coil with a predetermined
5 thickness.

According to another specific form of the present invention, there is provided a method for producing a high density inductor comprising the steps of forming a coil having a spiral shape,
10 sealing the coil in the interior of a core member, and forming a terminal electrode for allowing electric conduction to the coil on the outside of the core member, wherein the coil is formed by a process comprising the steps of forming a groove portion
15 corresponding to the shape of the coil in a resist by photo etching, depositing a metal in the groove by plating to form a wire layer, then applying the resist again up to a height corresponding to a next wire layer, forming a groove portion on top of the
20 wire layer by photo etching again, then forming an additional wire layer by depositing the metal in the groove portion by plating, and repeating piling-up of the wire layers to form the coil with a predetermined thickness.

25 In the above-described method according to the present invention, the wire layers may be formed by sputtering instead of plating.

After the above-described process, the coil may be sealed in the core member by forming the coil on a dummy substrate, inserting the coil into the core member while maintaining the aforementioned state, and then removing a part or the whole of the dummy substrate. In addition, the coil may be fixed and sealed by injecting an organic or inorganic adhesive into the interior of the core member and curing the adhesive. Furthermore, an electrode lead-out portion for the coil may be formed on a side surface of the coil either directly or with an insulating layer between after the coil is sealed. Alternatively, after the coil is sealed, a side surface of the coil may be smoothed by grinding, and an electrode lead-out portion for the coil may be formed on the side surface of the coil either directly or with an insulating layer between.

According to the above-described features of the present invention, since a thin film formation process is used to shape a coil, the coil can be made compact and shaped precisely. Consequently, the size of a core member enveloping the coil can also be reduced. Thus, the inductor itself can be made compact.

According to the invention, the coil has a structure in which a plurality of wire layers are piled up, wherein the ratio of the thickness to the

wire width or the aspect ratio of each wire layer is designed to be low. In the case that each wire layer is formed by a thin film formation process, it is possible to prevent resist in which a groove portion
5 has been formed from bending or collapsing by setting the aspect ratio as low as a value with which collapse or detachment of the resist is hard to occur. Therefore, it is possible to form a wire layer reliably. Thus, a coil with a large thickness
10 dimension or a high aspect ratio can be eventually formed by repeating the thin film formation process to pile up the wire layers each of which has a low aspect ratio.

When a coil is formed by piling up wire layers
15 by a thin film formation process as described above, it is not necessary to insert, for example, a sheet member or the like in a space inside the coil. Therefore, the structure in which only the coil is enveloped in the core member without any other member
20 can be realized. As a result, it is possible to produce a high density inductor. In addition, since only the coil is enveloped, the inductor can be made compact.

According to a preferred form of the present
25 invention, a coil formed on a dummy substrate is inserted in a core member and then the dummy substrate is removed or detached to isolate the coil.

In addition, the coil may be sealed in the core member in such a way that a closed magnetic path is formed. In this way, it is possible to attain downsizing and density enhancement of the inductor.

5 Thus, the mount area and height of the inductor can be reduced. In addition, a smoothing processing by grinding may be performed upon forming an electrode lead-out portion. With that process, it is possible to form the electrode lead-out portion more precisely.

10 These and other features of the present invention will become apparent by reading the following detailed descriptions of the invention made with reference to the accompanying drawings.

15 BRIEF DESCRIPTION OF THE DRAWINGS

Fig. 1A is a perspective view showing the structure of a high density inductor according to an embodiment of the present invention.

20 Fig. 1B is a cross sectional view taken along line 1B-1B in Fig. 1A showing the structure of the high density inductor according to the embodiment of the present invention.

Fig. 2 is an enlarged view showing a part of the high density inductor shown in Figs. 1A and 1B.

25 Fig. 3A is a process diagram illustrating a first method for forming a coil.

Fig. 3B is a process diagram illustrating the

first method for forming a coil.

Fig. 3C is a process diagram illustrating the first method for forming a coil.

Fig. 3D is a process diagram illustrating the
5 first method for forming a coil.

Fig. 3E is a process diagram illustrating the first method for forming a coil.

Fig. 3F is a process diagram illustrating the first method for forming a coil.

10 Fig. 3G is a process diagram illustrating the first method for forming a coil.

Fig. 3H is a process diagram illustrating the first method for forming a coil.

Fig. 3I is a process diagram illustrating the
15 first method for forming a coil.

Fig. 3J is a process diagram illustrating the first method for forming a coil.

Fig. 3K is a process diagram illustrating the first method for forming a coil.

20 Fig. 3L is a process diagram illustrating the first method for forming a coil.

Fig. 3M is a process diagram illustrating the first method for forming a coil.

Fig. 3N is a process diagram illustrating the
25 first method for forming a coil.

Fig. 3O is a process diagram illustrating the first method for forming a coil.

Fig. 4A is a process diagram illustrating a second method for forming a coil.

Fig. 4B is a process diagram illustrating the second method for forming a coil.

5 Fig. 4C is a process diagram illustrating the second method for forming a coil.

Fig. 4D is a process diagram illustrating the second method for forming a coil.

10 Fig. 4E is a process diagram illustrating the second method for forming a coil.

Fig. 4F is a process diagram illustrating the second method for forming a coil.

Fig. 4G is a process diagram illustrating the second method for forming a coil.

15 Fig. 4H is a process diagram illustrating the second method for forming a coil.

Fig. 4I is a process diagram illustrating the second method for forming a coil.

20 Fig. 4J is a process diagram illustrating the second method for forming a coil.

Fig. 4K is a process diagram illustrating the second method for forming a coil.

Fig. 4L is a process diagram illustrating the second method for forming a coil.

25 Fig. 4M is a process diagram illustrating the second method for forming a coil.

Fig. 5A is a process diagram for producing

inductors.

Fig. 5B is a process diagram for producing inductors.

Fig. 5C is a process diagram for producing
5 inductors.

Fig. 5D is a process diagram for producing inductors.

Fig. 5E is a process diagram for producing inductors.

10 Fig. 5F is a process diagram for producing inductors.

Fig. 5G is a process diagram for producing inductors.

Fig. 5H is a process diagram for producing
15 inductors.

Fig. 5I is a process diagram for producing inductors.

Fig. 5J is a process diagram for producing inductors.

20 Fig. 6A is an enlarged view showing one unit in one of the stages of the process for producing inductors.

Fig. 6B is an enlarged view showing one unit in one of the stages of the process for producing
25 inductors.

Fig. 6C is an enlarged view showing one unit in one of the stages of the process for producing

inductors.

Fig. 6D is an enlarged view showing one unit in one of the stages of the process for producing inductors.

5 Fig. 6E is an enlarged view showing one unit in one of the stages of the process for producing inductors.

Fig. 6F is an enlarged view showing one unit in one of the stages of the process for producing
10 inductors.

Fig. 6G is an enlarged view showing one unit in one of the stages of the process for producing inductors.

Fig. 6H is an enlarged view showing one unit in
15 one of the stages of the process for producing inductors.

Fig. 7A is a perspective view showing an inductor according to a first prior art.

Fig. 7B is a perspective view showing the
20 inductor according to the first prior art.

Fig. 8A illustrates a stage of a process for producing an inductor according to a second prior art.

Fig. 8B illustrates a stage of the process for producing the inductor according to the second prior
25 art.

Fig. 9A is a process diagram illustrating a stage of process for forming a coil using thin film

formation technology.

Fig. 9B is a process diagram illustrating a stage of the process for forming a coil using thin film formation technology.

5 Fig. 9C is a process diagram illustrating a stage of the process for forming a coil using thin film formation technology.

Fig. 9D is a process diagram illustrating a stage of the process for forming a coil using thin
10 film formation technology.

Fig. 10 is a perspective view showing a coil that is formed using thin film formation technology.

Fig. 11A illustrates a stage of a process for forming a coil using plating.

15 Fig. 11B illustrates a stage of the process for forming a coil using plating.

Fig. 11C illustrates a stage of the process for forming a coil using plating.

Fig. 11D illustrates a stage of the process for
20 forming a coil using plating.

Fig. 12 shows a state in which resist is bent or removed.

Fig. 13 is a cross sectional view showing a substrate on both side of which coils are formed.

25

DESCRIPTION OF THE PREFERRED EMBODIMENTS.

In the following, specific preferred

embodiments of a high density inductor and a method of producing a high density inductor according to the present invention will be specifically described with reference to the drawings.

5 Fig. 1A is a perspective view showing the backside of a high density inductor according to an embodiment of the present invention. Fig. 1B is a cross sectional view of the inductor taken along line 1B-1B in Fig. 1A. Fig. 2 is an enlarged view showing
10 a part of the inductor shown in Fig. 1B. As shown in these drawings, the high density inductor according to this embodiment includes a coil 22 disposed at the center of the inductor 20 and a core member for sealing the coil 22. On the backside of the inductor
15 20, there is provided a pair of connection terminals 24 and 26, with which the inductor can be mounted on a printed circuit board or the like.

 The coil 22 has a layered structure in which a plurality of wire layers 28 (four layers, in this
20 embodiment) are piled up in the thickness direction, so that a high aspect ratio is attained. The coil 22 is formed in a spiral shape with a constant radial pitch from the inner portion to the outer portion. This coil 22 can be formed utilizing a thin film
25 process that is used in producing semiconductor devices. In the following, a process of forming the coil 22 by means of a thin film process will be

described.

Figs. 3A to 30 are process diagrams illustrating a first method for forming a coil. Firstly, an insulating layer 32 is formed on a substrate 30 serving as a base for the coil 22 to be formed as shown in Fig. 3A. Then, as shown in Fig. 3B, a base electrode layer 34 used for deposition by plating is deposited on the upper surface of the insulating layer 32 by vapor deposition or sputtering. After the base electrode layer 34 is formed, a resist (i.e. a photosensitive resin) 36 is applied on the base electrode layer 34 with a uniform thickness. The thickness of the resist coating 36 should correspond to the thickness of each wire layer 28. It is preferable that the resist 36 be applied by a spin coating process in order for its coating thickness to be made uniform.

After the resist 36 is applied with a uniform thickness, the surface of the resist 36 is irradiated with ultraviolet radiation by means of a stepper apparatus or the like, and thereafter a groove portion 38 that defines the plan configuration of the coil 22 (i.e. the configuration or shape of the coil 22 as viewed from above) is formed in the resist 36 by photo etching. This state is shown in Fig. 3D. Then the substrate 30 is dipped in a plating solution and a voltage is applied while using the base

electrode layer 34 as one of the electrodes. As a result, a metal is deposited on the groove portion 38 at the bottom of which the base electrode layer 34 is exposed, so that the groove portion 38 is stopped
5 with the deposit member 40. After the groove portion 38 is stopped by the deposit member 40, the resist 36 that defines the groove portion 38 is removed. Thus, a wire layer 28 having a plan configuration corresponding to the coil 22 is formed.

10 Next, in the following, a process of forming an additional layer on top of the wire layer 28 will be described. In connection with this, in this embodiment, all of the wire layers to be piled up are designed to have the same thickness, and the wire
15 layers and related portions will be designated with the same reference signs throughout the description.

After the lowermost wire layer 28 is formed on the substrate 30, as shown in Fig. 3G, new resist 36 is firstly applied on the base electrode layer 34 in
20 a manner similar to the process shown in Fig. 3C. What is different in the state shown in Fig. 3G from the state shown in Fig. 3C is the height (or the thickness) of the resist 36. Specifically, in the state shown in Fig. 3G, the thickness of the resist
25 36 is set to correspond to the height of the two layers of the wire layers 28. After the resist 36 is applied up to the prescribed thickness, an additional

wire layer 28 (i.e. the second layer) is formed utilizing the resist 36 on which a groove portion 38 has been formed by photo etching in the same manner as the process shown in Figs. 3D to 3F, as shown in
5 Figs. 3H to 3J.

After the additional wire layer 28 is formed, resist 36 is newly applied on the substrate 30 up to the height corresponding to three wire layers. Then, as shown in Figs. 3L to 3M, a further additional wire
10 layer 28 (i.e. the third layer) is formed utilizing the resist 36 on which a groove portion 38 has been formed by photo etching in the same manner as the operations shown in Figs. 3D to 3F and in Figs. 3H to 3J. In addition, under the state in which the resist
15 36 has been removed as shown in Fig. 3N, the exposed base electrode layer 3 is removed by etching or a like process as shown in Fig. 3O.

Figs. 4A to 4M are process diagrams according to a second method for forming a coil. In the
20 description of the second method, the portions same as the portions in the above-described first method will be designated by the same reference numerals.

The processes shown in Figs. 4A to 4E are the same as the processes shown in Figs. 3A to 3E
25 described above. With those processes, an insulating layer 32 is formed on a substrate 30, resist 36 is applied on a base electrode film 34, a groove portion

38 is formed in the resist 36 by photo etching, and then a deposit member 40 is formed in the groove portion 38 by deposition process in a plating solution.

5 After the deposit member 40 is formed in the grooved portion 38, the resist 36 is heated or the surface of the resist 36 is covered with a thin film of poly vinyl alcohol or the like so that the resist will not be mixed with resist that will be further
10 applied on it. (This process should be done in order to prevent the state that the underlying resist is dissolved by the solvent of the applied resist to partially spread over the coil and to generate scum that affects the deposit member.) After that,
15 additional resist 42 is applied on top of the resist 36 and the deposit member 40 as shown in Fig. 4F. The coating thickness of the additional resist 42 is designed to correspond to the thickness of one wire layer 28. Then, a groove portion 38 is formed in the
20 resist 42 by photo etching as shown in Fig. 4G, and the deposit member 40 as the second layer is formed in the groove portion 38 by deposition in a plating solution.

 After the second layer of the deposit member 40
25 is formed in the groove portion, new resist 44 is applied on top of the resist 42 and the deposit member 40 as shown in Fig. 4I. Then, a photo etching

process and a deposition process are carried out as shown in Figs. 4J and 4K, so that the third layer of the deposit member 40 is formed.

After the third layer of the deposit member 40 is formed, the resist 36, the resist 42 and the resist 44 are removed at one time as shown in Fig. 4L and then the exposed base electrode layer 34 is removed by etching or a like process as shown in Fig. 4M.

According to the above-described production method, although the aspect ratio or the ratio of the height (or thickness) to the width of each wire layer 28 is small, a coil 22 with a high aspect ratio can be formed by piling up the multiple wire layers 28. In addition, since the wire layers are formed by photo etching, the precision of formation is of the order of microns. Therefore, it is possible to form a compact and high density wire layer with a small line pitch.

Since the coil 22 described above is formed by a thin film process, a plurality of coils 22 can be produced on the substrate 30. In other words, this production method has the additional advantage that many coils 22 can be produced by one production cycle. With such mass production, the cost of producing the coil 22 can be reduced.

The inventor carried out experiments in order

to test the effects of the present invention. The results of the experiment will be presented in the following as an example.

(Example)

5 A coil pattern was formed on a substrate having a base conductive layer. For example in the case that a coil pattern with a thickness of the electroconductive portion of $40\mu\text{m}$ and a width of the coil interval space of $10\mu\text{m}$ is to be formed, the
10 width of the resist pattern should be $10\mu\text{m}$. The allowable height for the resist of the aforementioned width with which the width of the resist will remain constant and the resist will not be bent is about $40\mu\text{m}$ or less. In order to ensure the resolution
15 realizing a resist width of $10\pm 2\mu\text{m}$ in both the upper and lower portions of the pattern, exposure light having a wavelength of 360nm was used.

With the above conditions, the first layer of the coils with the coil width of $40\mu\text{m}$ and a spacing
20 of $10\mu\text{m}$ was formed.

At that time, all of the coils of the first layer were normally formed on the substrate without being bent, in other words the process yield was 100%.

Next, a pattern of the second layer was formed
25 on top of the first layer. The pattern resist was processed at 130°C for one hour, and then resist was applied with a thickness of $40\mu\text{m}$. After that, the

resist was exposed to a pattern with a resist width of $10\mu\text{m}$, and then plating was performed.

Thus, coils were formed as a pile of the first layer and the second layer, in which high aspect
5 coils with a spacing of $10\mu\text{m}$ and a coil height of $80\mu\text{m}$ were formed at a yield of nearly 100%.

Then a pattern of the third layer was formed on top of the second layer. The pattern resist was processed at 130°C for one hour, and then resist was
10 applied with a thickness of $40\mu\text{m}$. After that, the resist was exposed to a pattern with a resist width of $10\mu\text{m}$, and then plating was performed.

Thus, coils were formed as a pile of the first, second and third layers, in which high aspect coils
15 with a spacing of $10\mu\text{m}$ and a coil height of $120\mu\text{m}$ were formed at a yield more than 95%.

On the other hand, we also formed a coil pattern with a resist thickness two times larger than the above process, i.e. with a thickness of $80\mu\text{m}$.

20 Resist was formed with a thickness of $80\mu\text{m}$, and a resist pattern with a width of $10\mu\text{m}$ was formed. Then a plating process was performed, and the resist was removed. We observed the resultant product to find that the yield of the coils was as low as 65%
25 or less due to bending of the resist or other defects.

Furthermore, we also performed application of resist with a thickness of $120\mu\text{m}$, exposure, and

development for patterning. However, a pattern could not be formed without being bent, and the yield of the coils was 0%.

As per the above, it was confirmed that the
5 coil structure and the method of producing coils according to the present invention is an essential technology for producing a high density thin film coil.

In the following, a process of forming an
10 inductor as an end product by sealing the coil 22 in a core member after the formation of the coil 22 on the substrate 30 will be described.

Figs. 5A to 5J are process diagrams showing a production process of inductors. Figs. 6A to 6H are
15 enlarged view showing one unit at some stages of the process.

Firstly, a substrate 30 shown in Fig. 5A on which coils 22 have been formed by the above-described method is cut, so that coil bars 46 each of
20 which includes coils 22 arranged in a row are formed. The coil bars 46 under the state in which they are cut from the substrate are shown in Fig. 5B, and one of the coils 22 formed on the coil bar 46 is shown in Fig. 6A.

25 After the coil bars 46 are cut out from the substrate 30, the coil bars 46 are turned over as shown in Fig. 5C and Fig. 6B, and the coils 22 are

inserted into an E-core 48 (before cut) disposed
below the coil bars 46. The E-core 48 will
constitute a part of the core member. The E-core 48
is made of a ferrite having a high magnetic
5 permeability. The E-core 48 has recessed portions 50.
The inner diameter and the depth of each recessed
portion 50 are large enough to receive a coil 22. At
the center of the recessed portion 52A, there is
provided a boss 52 having a diameter small enough to
10 be inserted into the central portion of the coil 22.
In addition, the outer diameter of the boss 52 is
sufficiently large so that magnetic fluxes 53
generated by the coil 22 can pass through it
sufficiently. (As to the magnetic flux path, see Fig.
15 1B.)

When the coils 22 are to be inserted in the E-
core 48, the aforementioned recessed portion should
be filled with a thermosetting adhesive so that the
coils 22 are dipped in the adhesive. Fig. 5D and Fig.
20 6C show the state in which the coil bars 46 are
dipped in the adhesive so as to be attached to the E-
core 48. The coil bars 46 and the E-core 48 thus
attached to each other are subjected to vacuum
heating so that air bubbles in the adhesive can be
25 removed to the exterior and the adhesive can be cured.

After the adhesive is cured and the coil bars
46 are adhered to the E-core 48, the substrate 30 is

ground from the backside so that the end face of the coils 22 is exposed as shown in Fig. 5E and Fig. 6D. After the end face of the coils 22 has been exposed, an insulating material is applied to the ground

5 surface at which the end face of the coils 22 is exposed so that a spacer layer 54 is formed, and then holes 56 are formed in the spacer layer 54 at the positions corresponding to both ends of each coil 22, as shown in Fig. 5F and Fig. 6E.

10 After the holes 56 are formed in the spacer layer 54, the end face of the coils 22 exposed at the holes 56 is nickel plated so that an oxide layer will not be formed. Then solder balls 58 are attached on the top layer as shown in Fig. 5G and Fig. 6F. The
15 solder balls are melted in a reflowing process at a later stage, so that the holes 56 are stopped by the melted solder. Thus, lead-out portions for electrodes are formed.

After the holes 56 formed in the spacer layer
20 54 are stopped by solder so that electric conduction to the coils 22 are made possible, covers 60 made of a ferrite for constituting the core member together with the E-core 48 is attached to the surface of the spacer 54 as shown in Fig. 5H and Fig. 6G. Each
25 cover has pairs of indentations 62 formed thereon. Each indentation 62 is designed to have a dimension (i.e. dimension C shown in Fig. 6G) corresponding to

the length from the end face of the cover to the hole
56 that has been stopped by solder. The inner
surface of the indentations 62 is covered with a
metal film such as Cu or Ni applied by plating or
5 sputtering or a solder film. The indentations 60 are
filled with solder and connection terminals 24 and 26
are formed by a reflowing process. Thus, electric
conduction to the coil 22 sealed by the E-core 48 and
the cover 60 is allowed. Finally, as shown in Fig.
10 5J, they are cut into individual pieces by a cutter
or the like, so that high density inductors according
to the present invention are formed.

In the high density inductor 20 produced by the
above-described process, what is accommodated in the
15 recessed portion 50 is only the coil 22 as shown in
Fig. 1B. Thus it is possible to reduce the size of
the inductor 20 having a low resistance that
generates little heat. In addition, it is possible
to reduce the height of the inductor with the removal
20 of the substrate by grinding.

As per the above, the high density inductor
according to the present invention can be
satisfactorily applied to hand-held devices or other
devices that are required to be reduced in size and
25 weight.

As has been described above, according to the
present invention, there is provided a method for

forming a high density inductor including a coil having a spiral shape and a core member disposed in such a way as to coincide with a path of a magnetic line of force generated by the coil, wherein the coil
5 has a structure in which a plurality of wire layers are piled up in the thickness direction. The wire layers are formed by a thin film forming process or by a process including the steps of forming a coil having a spiral shape, sealing the coil in the
10 interior of a core member, and forming a terminal electrode for allowing electric conduction to the coil on the outside of the core member. In this process, the coil is formed by repeating a process of forming a wire layer by means of a thin film forming
15 process and a process of forming an additional wire layer on top the wire layer by means of the thin film forming process to pile up the wire layers. With this method, it is possible to produce a coil having a high aspect ratio. According to a preferred form
20 of the invention, a dummy substrate on which the coil is formed is removed upon forming the inductor and only the coil is accommodated in the core member. With this feature, it is possible to reduce the size of the inductor and increase the density of the
25 inductor.

Furthermore, according to a preferred form of the invention a lead-out pattern for the coil can be

formed on the surface from which a dummy substrate
has been removed after the coil is sealed so that
terminal electrodes electrically connected with the
coil are formed on the outer surface of the core
5 member. With this feature, it is possible to reduce
the size of the inductor as a whole.

In the case that the prime demand is reduction
of the thickness of the inductor, the coil may be
formed as a single layer. In this case also, it is
10 possible with the present invention to reduce the
size of the inductor by removal of a substrate and
increase the density of the coil while reducing the
cost.